



U.S. Department of Energy
Energy Efficiency
and Renewable Energy

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DOE Solar Energy Technologies Program Peer Review

Interface and Electrode Engineering for Next-Generation Organic Photovoltaic Cells

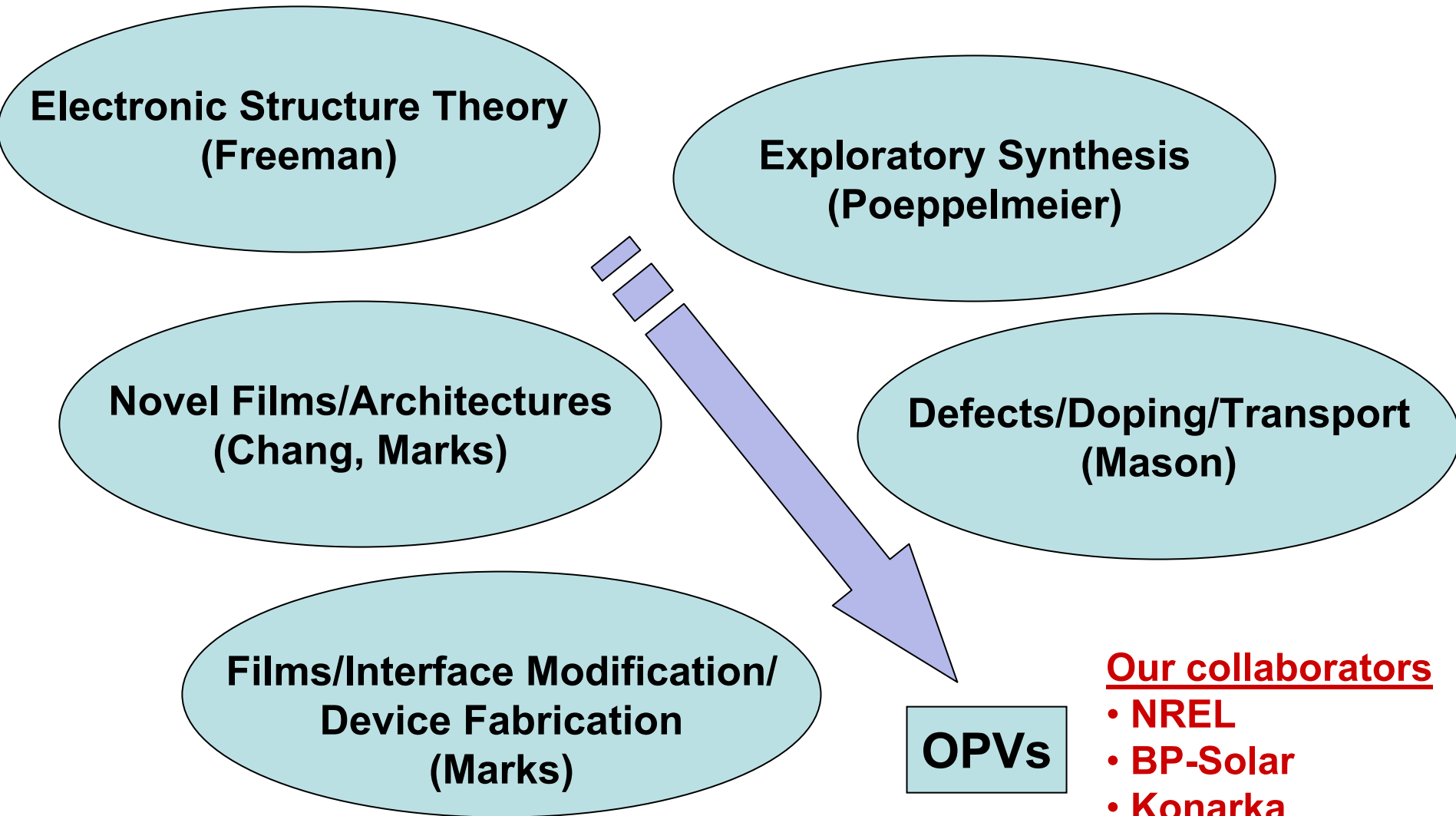
Denver, Colorado
April 17-19, 2007

Research Relevance/Objective

“...to address the near term and long-term Future Generation PV goals by interface and electrode engineering to enable next-generation, efficient, easily manufacturable, and durable organic photovoltaics (OPVs).”

- **Improved transparent electrode materials (transparent conducting oxides, TCOs) for OPVs**
- **Improved electrode-organic interfaces in OPVs**

Summary Of Activities



Outline

- Background
- TCO Surface Electronic Structure
- CdO and Double Layer ClO/ITO Films
- Donor-Doped (?) Delafossite

Accomplishments

Parent Oxides

- **CdO**
- **SnO₂**
- **In₂O₃**
- **ZnO**
- **Ga₂O₃**
- **ZnGa₂O₄**
- **In₄Sn₃O₁₂**
- **Zn_kIn₂O_{k+3} (k=3,7-15 odd)**
- **Zn₂In₂O₅ (k=2)**
- **MgIn₂O₄**
- **12CaO•7Al₂O₃**

Binary Compounds

- **Cd₂SnO₄**
- **CdIn₂O₄**
- **CdSnO₃**
- **ZnSnO₃**
- **Zn₂SnO₄**

Binary Solid Solutions

- **Ga_{2-2x}In_{2x}O₃**

Ternary Compounds

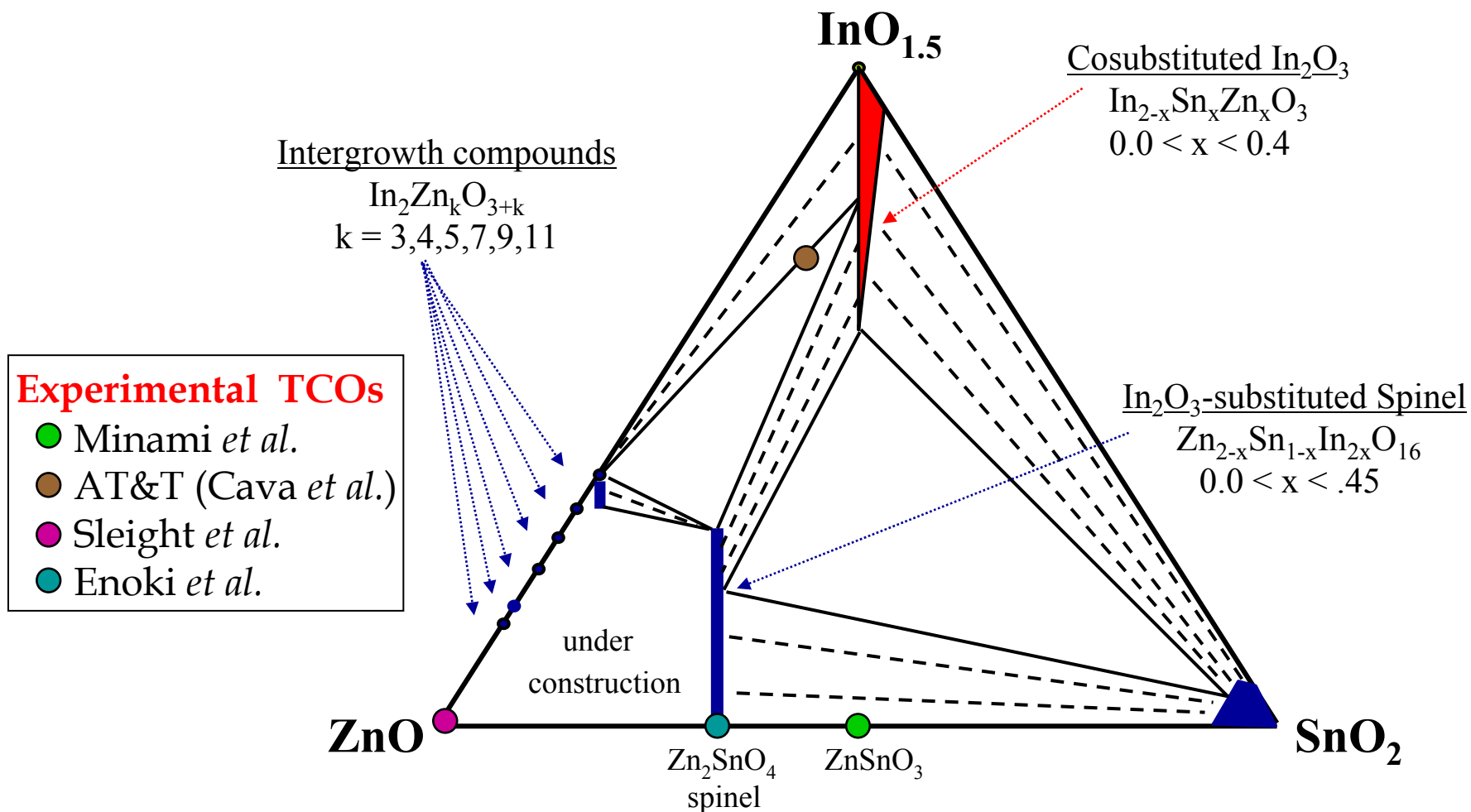
- **Ga_{3-x}In_{5+x}Sn₂O₁₆**

Ternary Solid Solutions

- **In_{1-x}Ga_{1+x}O₃(ZnO)_k (k=1,2,3)**
- **Zn_{2-x}Sn_{1-x}In_{2x}O₄**
- **In_{2-2x}Sn_xZn_xO₃**
- **xCd₂SnO₄-(1-x)CdIn₂O₄**
- **In_{2-2x}Cd_xSn_xO₃**
- **Cd_{1-x}Sn_{1-x}In_{2x}O₃**
- **xZn₂SnO₄-(1-x)ZnGa₂O₄**

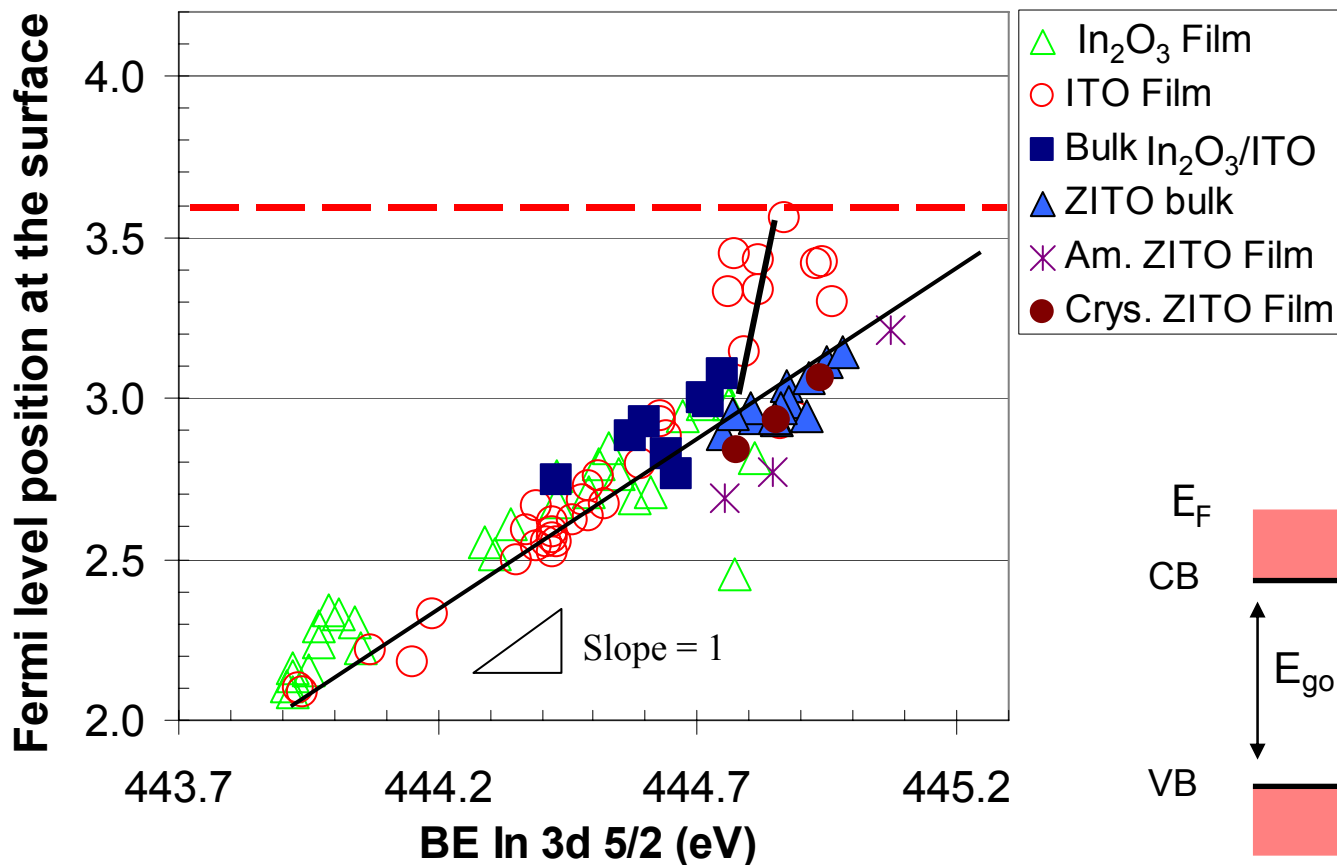
- New TCOs have electrical conductivities comparable to or greater than ITO making current collection more efficient
- Transparency windows broader than ITO allowing greater solar fluency to reach the active layer
- Greater chemical stability towards corrosion.

ZnO-In₂O₃-SnO₂ at 1250°C

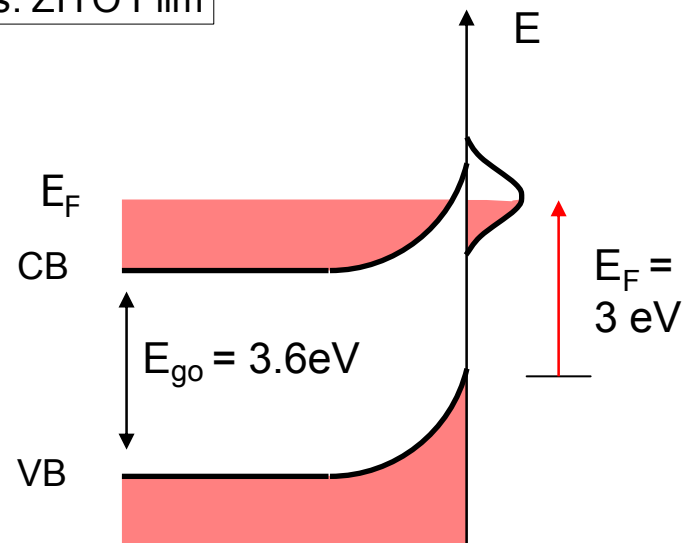


Surface Depletion in Bixbyite TCOs

- For all bixbyite materials investigated, the surface E_F position is lower than the intrinsic gap of In_2O_3 (which is 3.6 eV, shown as red line in plot below).
- This, combined with optical transmission data for films confirming a bulk band gap > 3.6 eV, is a direct indication of surface depletion effects.

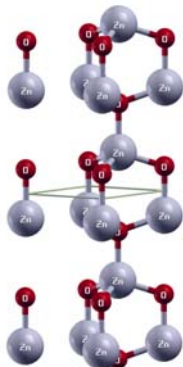


Past 3 eV and the “kink” in the diagram there is evidence for populated surface states and screening effects, shown schematically below. NOTE: ZITO differs from ITO behavior



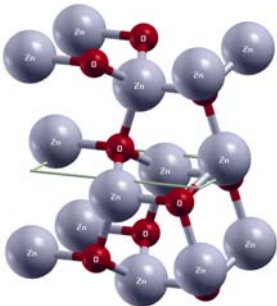
Work functions of polar and nonpolar ZnO surfaces by FLAPW

(0001)



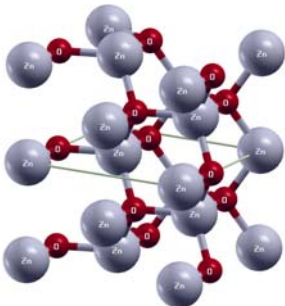
	Work Functions			
	Non-Relaxed		Relaxed	
	Cation Surface	Anion Surface	Cation Surface	Anion Surface
LDA (eV)	3.95	8.76	3.34	7.43
GGA (eV)	3.57	8.38	3.11	7.28

(1010)

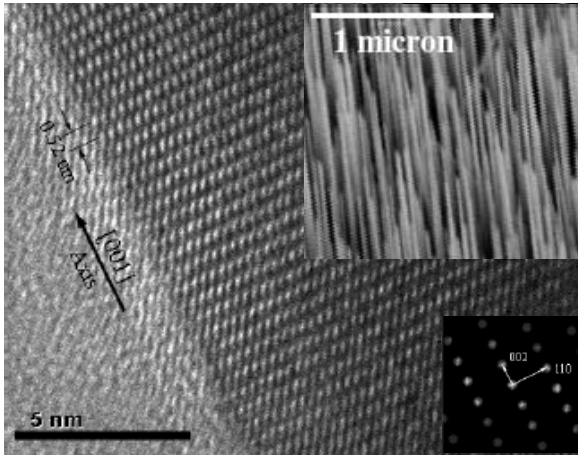


	Work Functions	
	Non-Relaxed	Relaxed
LDA (eV)	5.06	5.31
GGA (eV)	4.50	4.78

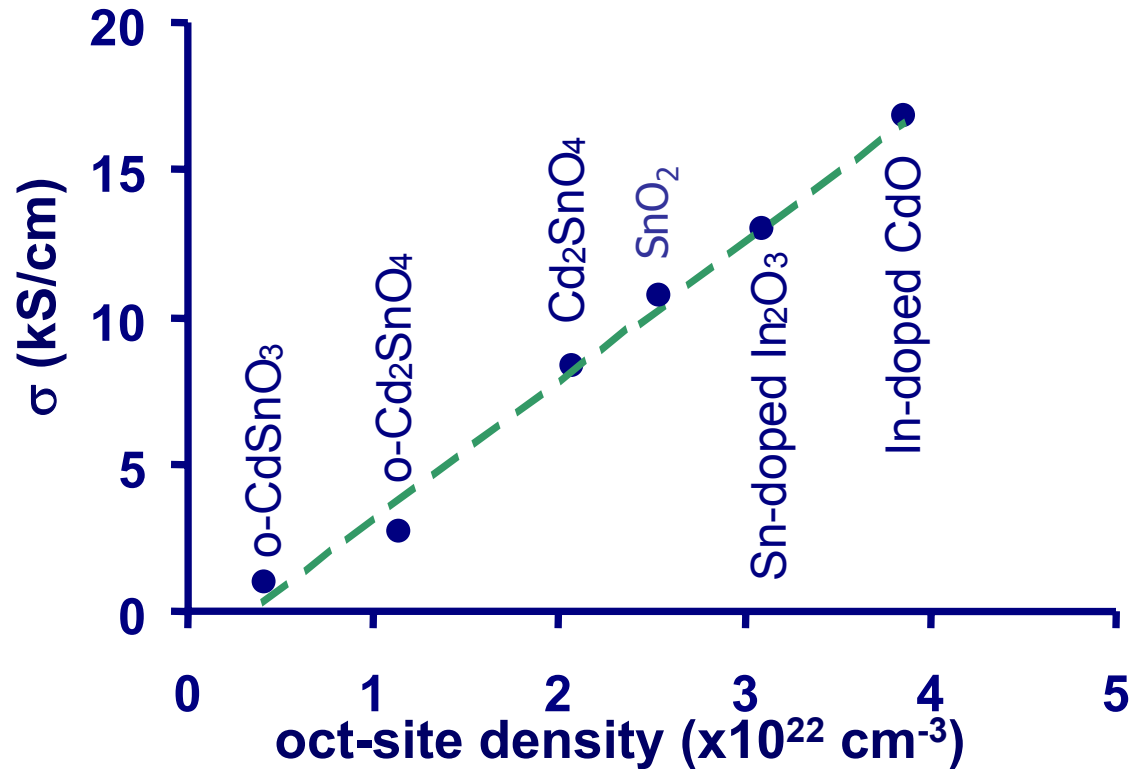
(1120)



	Work Functions	
	Non-Relaxed	Relaxed
LDA (eV)	5.14	5.19
GGA (eV)	4.58	4.76



Conductivity vs. Octahedral Site Density



o-CdSnO₃: R. D. Shannon, et al, J. Phys. Chem. Solids, 38, 877 (1977).

G. Haacke, Appl. Phys. Lett., 28, 622 (1976).

Cd₂SnO₄ : X. Wu, et al, J. Vac. Sci. Technol., A15, 1057 (1997).

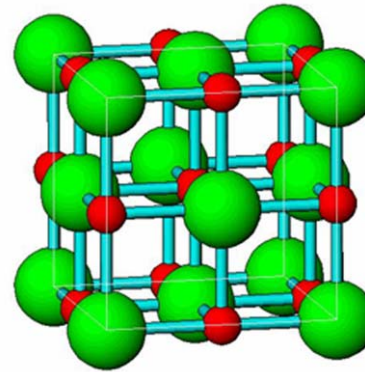
Sn-doped In₂O₃: H. Ohta, et al, J. Appl. Phys., 91[6] 3547 (2002).

In-doped CdO: A. Wang, et al, Proc. Nat. Acad. Sci., 98, 7113 (2001).

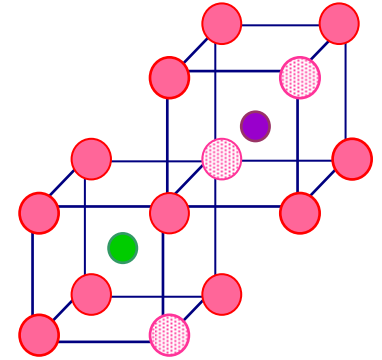
CdO Properties

CdO

Simple Cubic Crystal Structure
Broad 5s Conduction Band
Low Carrier Effective Masses



Rock Salt



Bixbyite

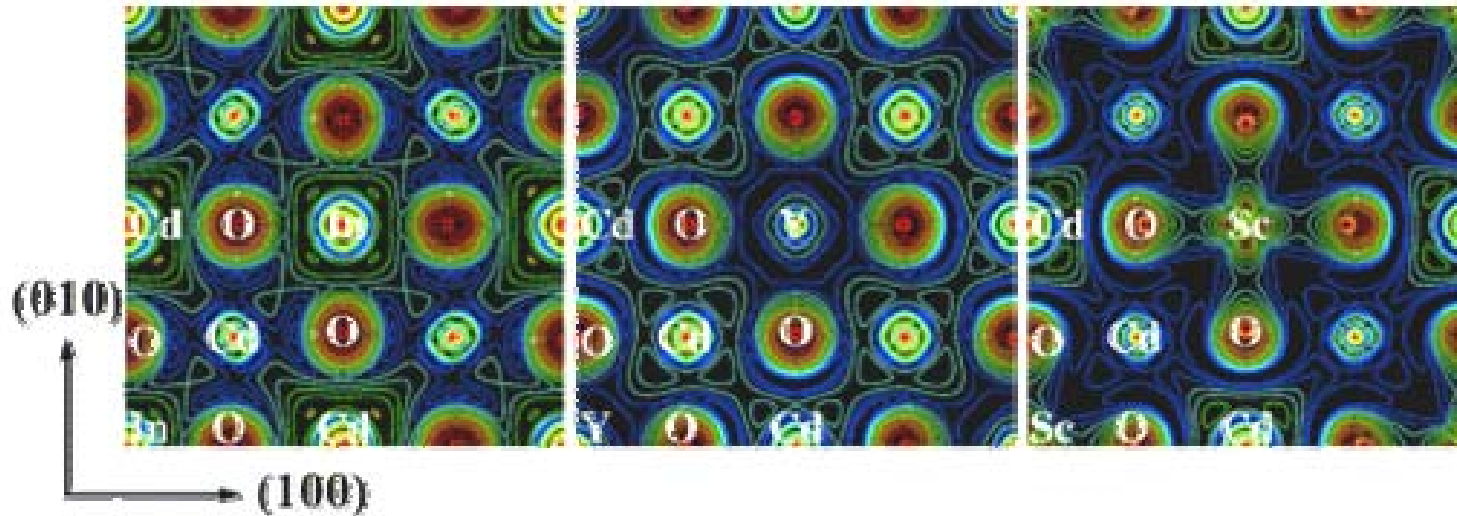
$\text{In}_x\text{Cd}_{1-x}\text{O}$

Simple, Homogeneously Doped Crystal Structure
Extensive Cd 5s + In 5s Mixing

- Uniform Charge Density, Fewer Ionized and Neutral Scattering Centers
 - Large Hopping Integrals, Low Effective Carrier Masses
- Burstein-Moss Shift Increases Gap (Transparency Window)
Burstein-Moss Shift Compensates for Gap Shrinkage

EXPERIMENT VS. THEORY. DOPED CdO BAND STRUCTURES

Vary Dopant Ionic Radius, Electronic Structure: In^{+3} , Y^{+3} , Sc^{+3}



Calculated charge density distribution in *ab* plane within energy window of 27 meV below Fermi level for In-, Y-, and Sc-doped CdO. Only atoms within one unit cell are labeled.

- Grain boundary scattering effects of minor importance in both epitaxial and polycrystalline CdO films
- Most effective dopants are those in which there is extensive hybridization of dopant and Cd^{+2} 5s states
- Burstein-Moss bandgap widening effects operative
- Small dopant ions can actually reduce Cd-O hybridization

Amorphous Substrates/MgO(100) Template Layers

Motivation

- ❖ CdO films on single-crystal substrates show better orientation & larger μ than on glass.
- ❖ Single-crystal MgO is best substrate to simultaneously achieve large μ & high orientation of CdO thin films.
- ❖ Smaller X-ray FWHM \rightarrow higher mobility.

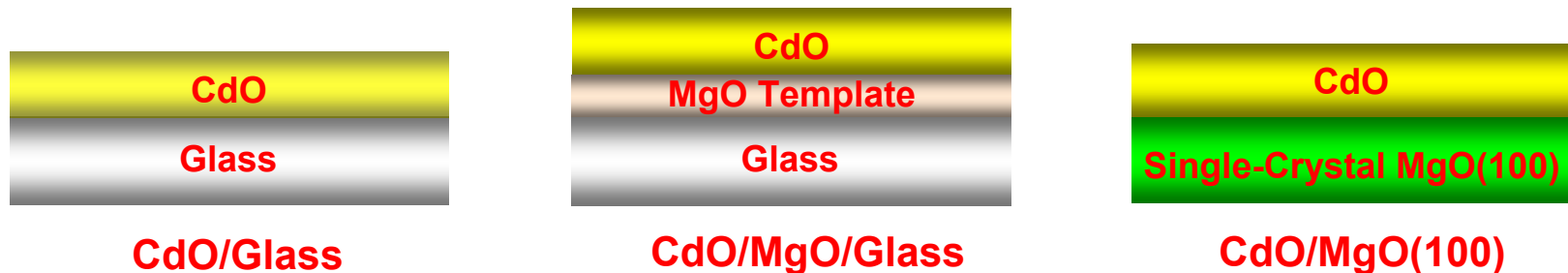
Benefits

- MgO: Widely used as template, buffer layer to induce oriented growth
- Reduce substrate cost vs. single-crystal substrates
- Negligible chemical effects on CdO films

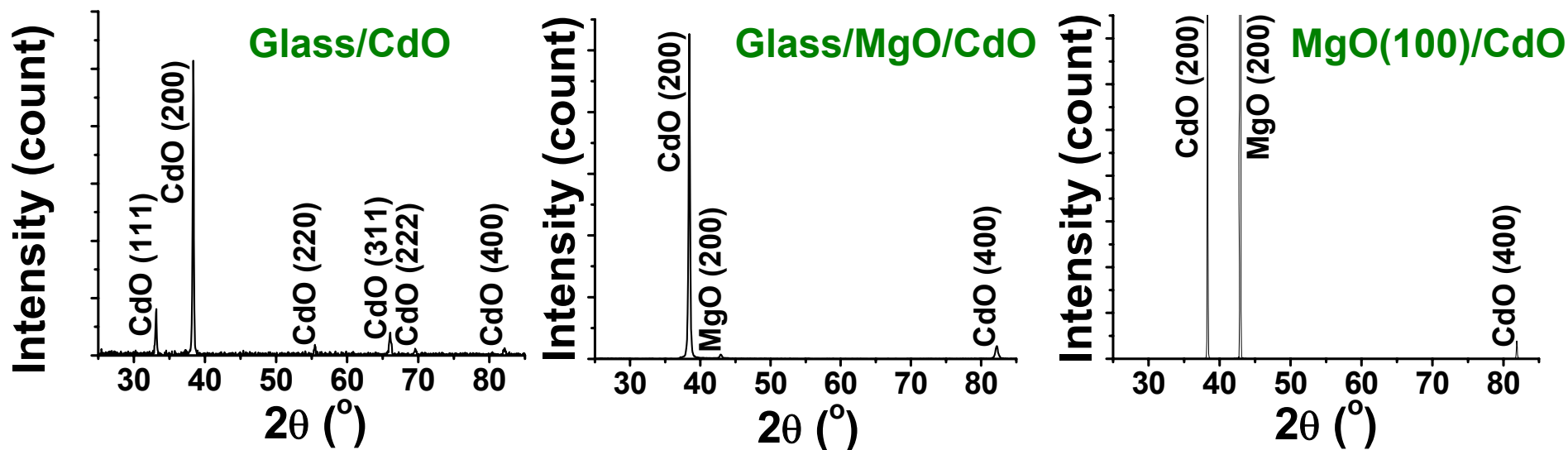
Template Strategy



Compare: CdO Growth on Three Different Substrates



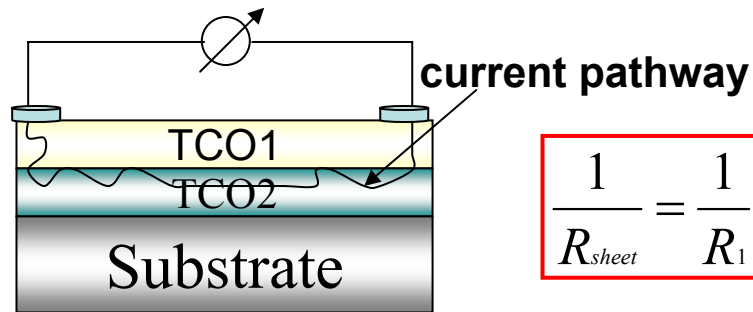
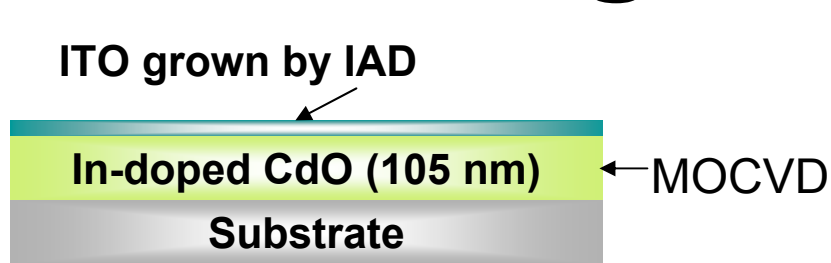
Parallel CdO Growth



Substrate	CdO Thickness (nm)	Conductivity (S/cm)	Carrier Concentration ($\times 10^{20} \text{ cm}^{-3}$)	Mobility ($\text{cm}^2/\text{V}\cdot\text{s}$)	X-Ray FWHM ($^\circ$)
Glass	290	5450 ± 80	2.58 ± 0.10	129 ± 8	19
MgO Template/Glass	310	6700 ± 210	2.65 ± 0.15	159 ± 5	2.1
Single-Crystal MgO(100)	690	8460 ± 200	2.33 ± 0.07	226 ± 10	0.4

CdO conductivity on MgO(100) template significantly improved due to increased crystallinity and mobility.

Tuning CdO Corrosion



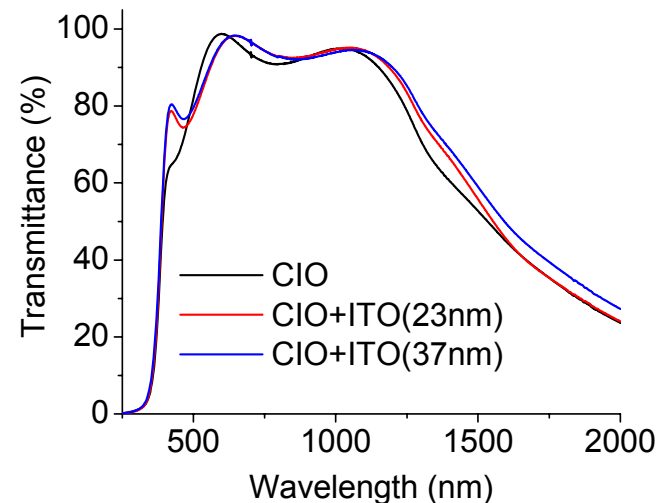
$$\frac{1}{R_{sheet}} = \frac{1}{R_1} + \frac{1}{R_2}$$

Sample	Thickness (nm)	Sheet Resistance (Ω/\square)	Transmittance (%)	Figure of Merit $\Phi = T/R_{sheet}$ ($10^{-3}\Omega^{-1}$)	In-Content (%)
CIO	167	5.6	86.4	41	4.3
CIO/ITO (23 nm)	180	5.6	87.1	45	15.8
CIO/ITO (37 nm)	194	6.1	88.0	46	21.4
ITO	130	18.0	95.1	34	90

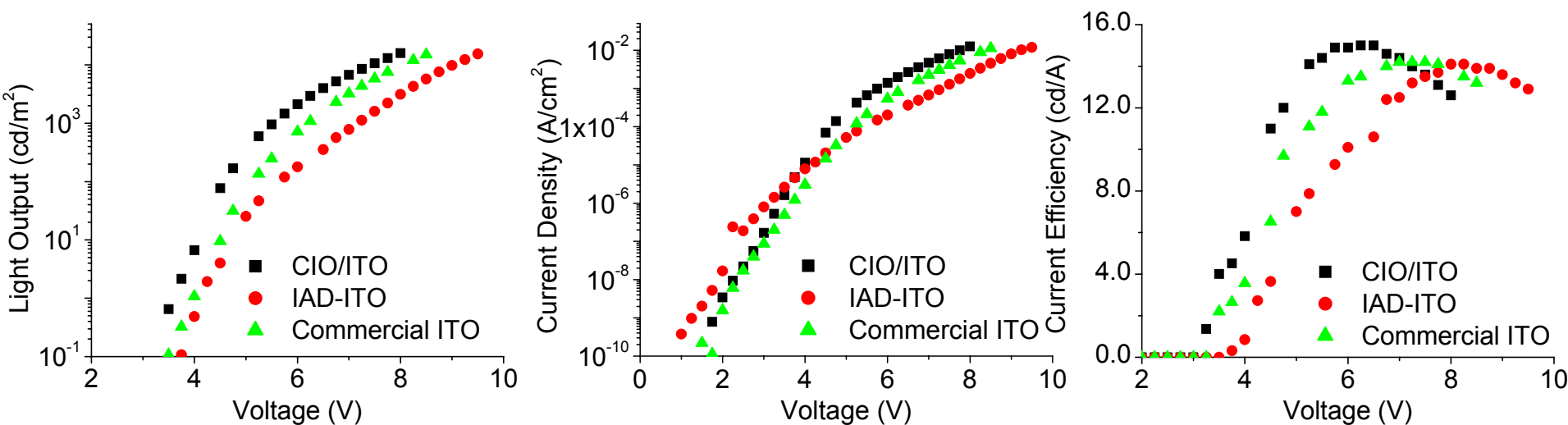
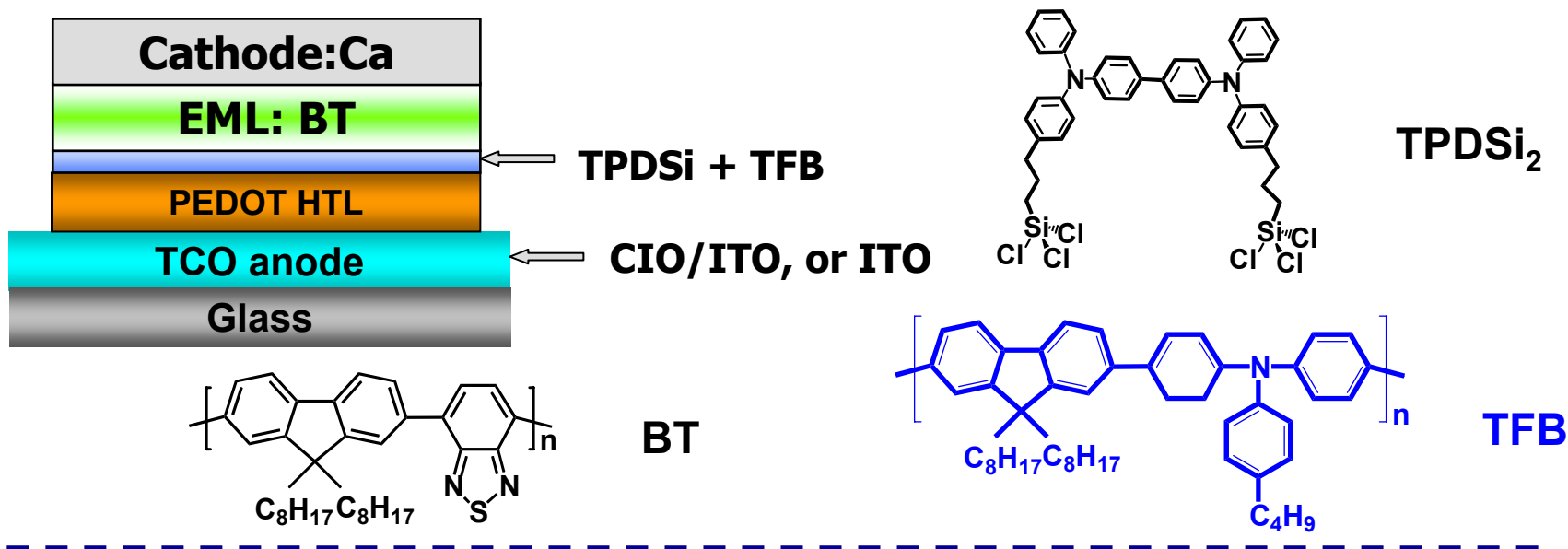
Payoff

- ✓ Lower sheet resistance, ideal for large scale displays
- ✓ Greater optical transparency, broader band gap
- ✓ Smoother surface morphology
- ✓ Tunable work function
- ✓ Higher environment stability, e.g. reducing atmosphere.
- ✓ Lower cost, reduce In content

Optical Properties



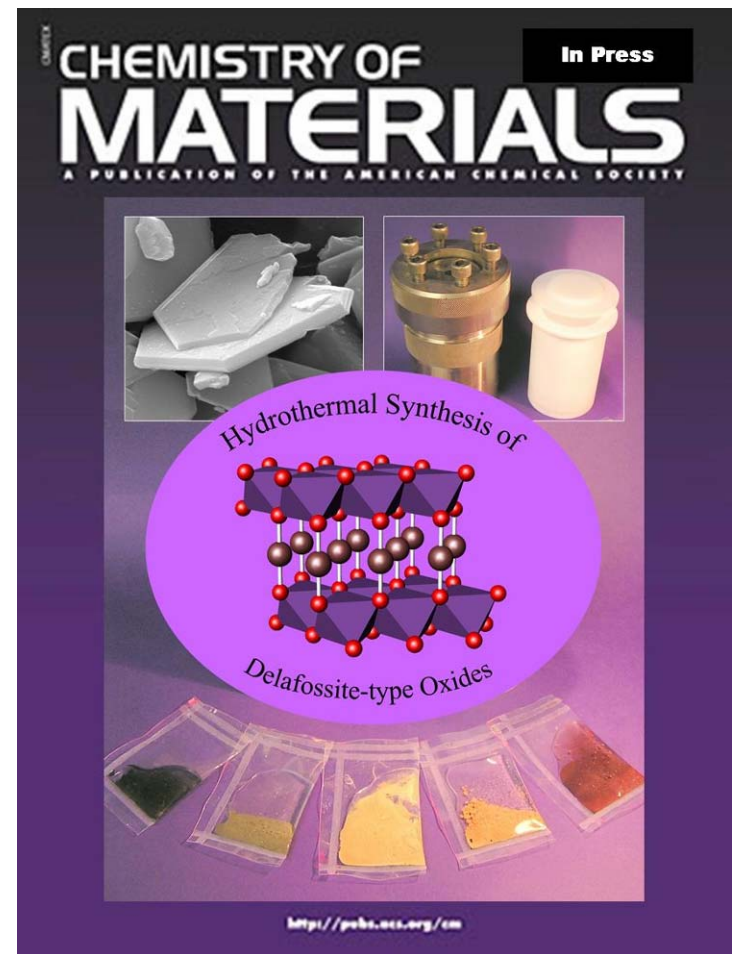
PLED Performance Using ClO/ITO Anodes



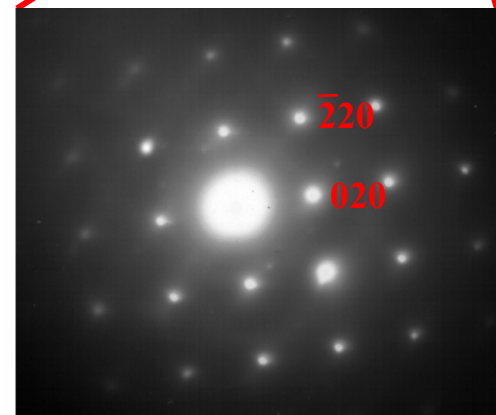
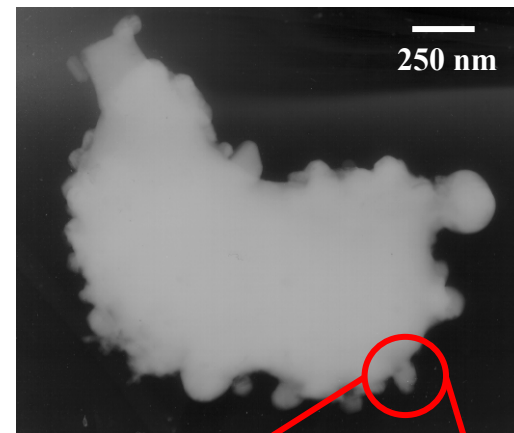
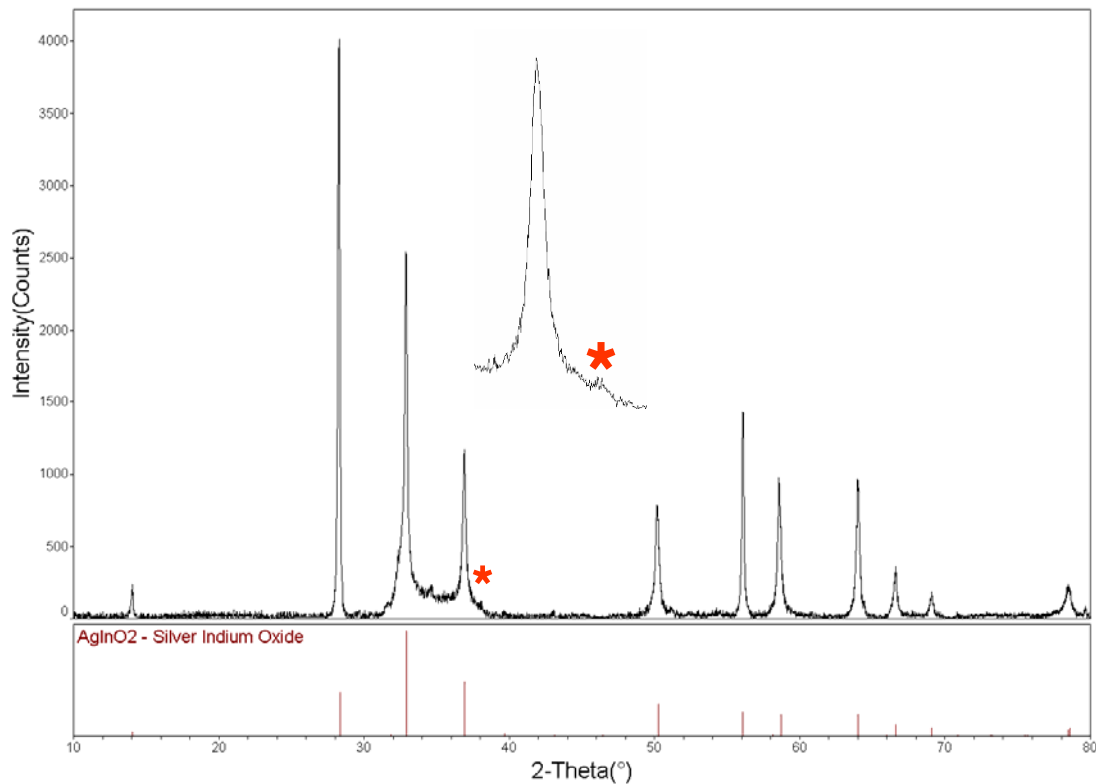
PLEDs based on double-layer TCOs exhibit lower turn-on voltage, higher light output and higher current efficiency--as high as 15 cd/A.

Delafossite-Type Oxides

- Hydrothermal process successfully overcomes challenges of prior synthetic methods by providing the first single step, *low temperature and pressure*, route by which delafossite-like materials can be fabricated *with phase purity*.
- CuAlO_2 , CuGaO_2 , (CuInO_2 missing !), CuScO_2 , CuFeO_2 (the mineral delafossite) and AgAlO_2 , AgGaO_2 , AgInO_2 (!!!), AgScO_2 , AgFeO_2 have been prepared in a similar fashion.
- Solid solution, $\text{CuAl}_{1-x}\text{Ga}_x\text{O}_2$ (where $0 \leq x \leq 1$), which is currently not accessible by a high temperature solid state method, also synthesized.



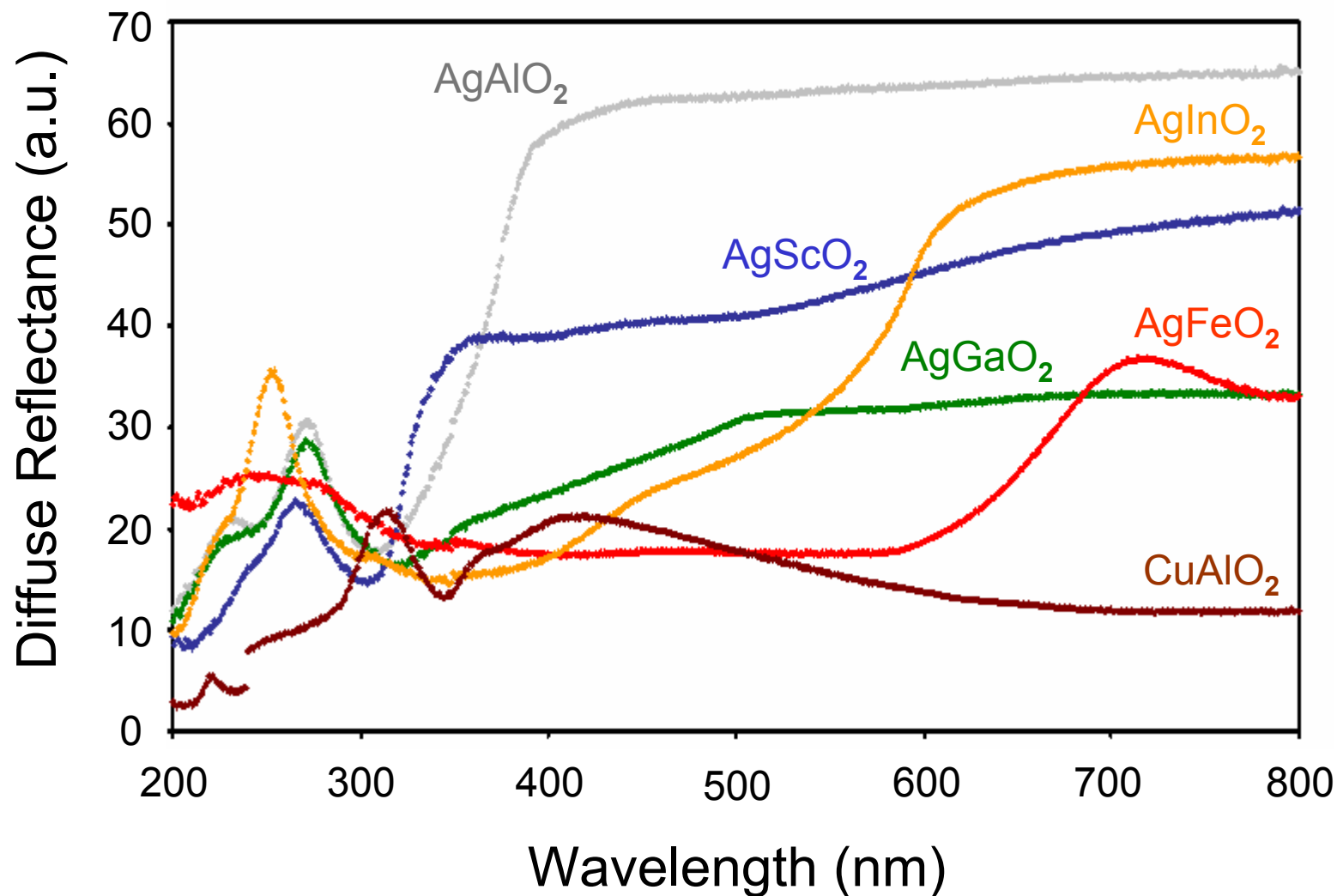
One-Step Synthesis of Ag-Delafossites



AgInO₂, as with all other Ag-delafoossites synthesized by this technique, has a minor amount of Ag⁰ present. This impurity can be traced back to the the Ag⁰ impurities present in the starting Ag₂O reagent (as seen in the TEM images to the right).

Ag [001] zone axis

Diffuse Reflectance

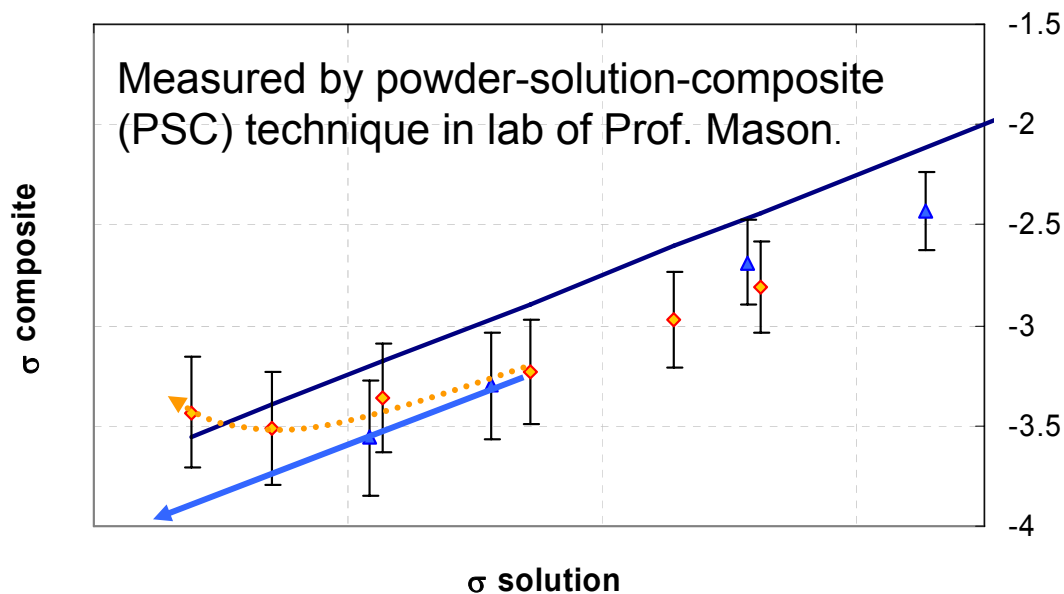


Hole Doping

A^I	31 Ga 69.72	13 Al 26.98	21 Sc 44.96	49 In 114.8
[B] mol/L	1	10 ⁻¹	10 ⁻⁴	10 ⁻⁵

-3.75 -3.25 -2.75 -2.25

Compounds	Form	σ (S/cm)
CuGaO ₂	powder	0.0056
CuGaO ₂	film	0.006
AgGaO ₂	crystal	2×10^{-8}
AgGaO ₂	film	3.2×10^{-4}
AgGaO₂	powder	$\leq 10^{-4}$



Major Scientific Issues

- Improper chemical and electronic matching between transparent electrodes and organic active layer
- Current losses and leakage at interfaces
- Poor adhesion/interfacial stability

Broad Future Plans

- TCO electrodes which are electronically, chemically, and surface compatible with the active organic elements of OPVs.
- Efficient current extraction, interfacial stable, charge-blocking layers for OPV.
- Basic science of the electrode interface leading to improved understanding and guidance for next-generation OPV materials design.